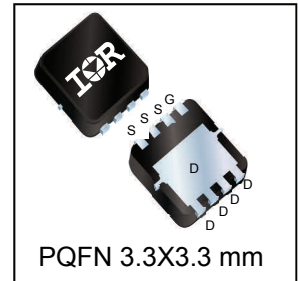
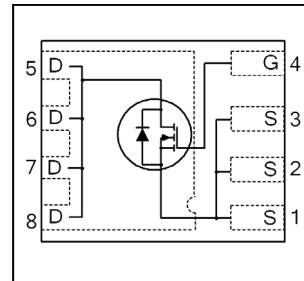


$V_{DSS}$	<b>30</b>	<b>V</b>
$V_{GS\ max}$	<b>±20</b>	<b>V</b>
$R_{DS(on)\ max}$ (@ $V_{GS} = 10V$ )	<b>4.7</b>	<b>mΩ</b>
(@ $V_{GS} = 4.5V$ )	<b>6.7</b>	
$Q_g$ (typical)	<b>20</b>	<b>nC</b>
$I_D$ (@ $T_C(Bottom) = 25°C$ )	<b>70</b> Ⓞ	<b>A</b>

HEXFET® Power MOSFET



**Applications**

- Charge and Discharge Switch for Notebook PC Battery Application
- System/Load Switch
- Synchronous MOSFET for Buck Converters

**Features**

Low Thermal Resistance to PCB (<3.4°C/W)
Low Profile (<1.05 mm)
Industry-Standard Pinout
Compatible with Existing Surface Mount Techniques
RoHS Compliant Containing no Lead, no Bromide and no Halogen
MSL1, Consumer Qualification

results in  
⇒

**Benefits**

Enable better thermal dissipation
Increased Power Density
Multi-Vendor Compatibility
Easier Manufacturing
Environmentally Friendlier
Increased Reliability

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFHM8326PbF	PQFN 3.3 mm x 3.3 mm	Tape and Reel	4000	IRFHM8326TRPbF

**Absolute Maximum Ratings**

	Parameter	Max.	Units
$V_{GS}$	Gate-to-Source Voltage	± 20	V
$I_D @ T_A = 25°C$	Continuous Drain Current, $V_{GS} @ 10V$	19	A
$I_D @ T_A = 70°C$	Continuous Drain Current, $V_{GS} @ 10V$	15	
$I_D @ T_C(Bottom) = 25°C$	Continuous Drain Current, $V_{GS} @ 10V$	70Ⓞ	
$I_D @ T_C(Bottom) = 100°C$	Continuous Drain Current, $V_{GS} @ 10V$	44Ⓞ	
$I_D @ T_C = 25°C$	Continuous Drain Current, $V_{GS} @ 10V$ (Source Bonding Technology Limited)	25⑦	
$I_{DM}$	Pulsed Drain Current ①	278	W
$P_D @ T_A = 25°C$	Power Dissipation ⑤	2.8	
$P_D @ T_C(Bottom) = 25°C$	Power Dissipation ⑤	37	
	Linear Derating Factor ⑤	0.023	W/°C
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 150	°C

Notes ① through ⑦ are on page 9

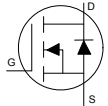
**Static @ T<sub>J</sub> = 25°C (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	30	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	—	22	—	mV/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	—	3.8	4.7	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A ③
		—	5.2	6.7		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 20A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.2	1.7	2.2	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 50μA
ΔV <sub>GS(th)</sub>	Gate Threshold Voltage Coefficient	—	-10	—	mV/°C	
I <sub>DSS</sub>	Drain-to-Source Leakage Current	—	—	1.0	μA	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V
		—	—	150		V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	—	—	100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage	—	—	-100		V <sub>GS</sub> = -20V
g <sub>fs</sub>	Forward Transconductance	70	—	—	S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 20A
Q <sub>g</sub>	Total Gate Charge	—	39	—	nC	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V, I <sub>D</sub> = 20A
Q <sub>gs1</sub>	Pre-V <sub>th</sub> Gate-to-Source Charge	—	4.8	—		
Q <sub>gs2</sub>	Post-V <sub>th</sub> Gate-to-Source Charge	—	2.6	—		
Q <sub>gd</sub>	Gate-to-Drain Charge	—	6.5	—		
Q <sub>godr</sub>	Gate Charge Overdrive	—	6.1	—		
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )	—	9.1	—		
Q <sub>oss</sub>	Output Charge	—	11	—		
R <sub>G</sub>	Gate Resistance	—	1.9	—	Ω	
t <sub>d(on)</sub>	Turn-On Delay Time	—	12	—	ns	V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V I <sub>D</sub> = 20A R <sub>G</sub> = 1.8Ω
t <sub>r</sub>	Rise Time	—	35	—		
t <sub>d(off)</sub>	Turn-Off Delay Time	—	18	—		
t <sub>f</sub>	Fall Time	—	12	—		
C <sub>iss</sub>	Input Capacitance	—	2496	—	pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 10V f = 1.0MHz
C <sub>oss</sub>	Output Capacitance	—	524	—		
C <sub>rss</sub>	Reverse Transfer Capacitance	—	273	—		

**Avalanche Characteristics**

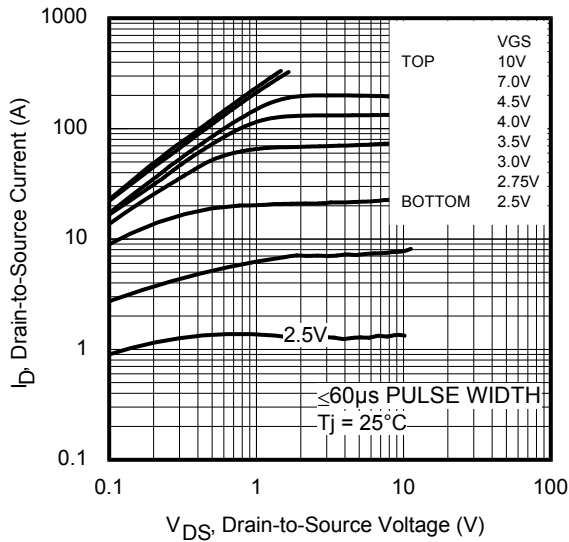
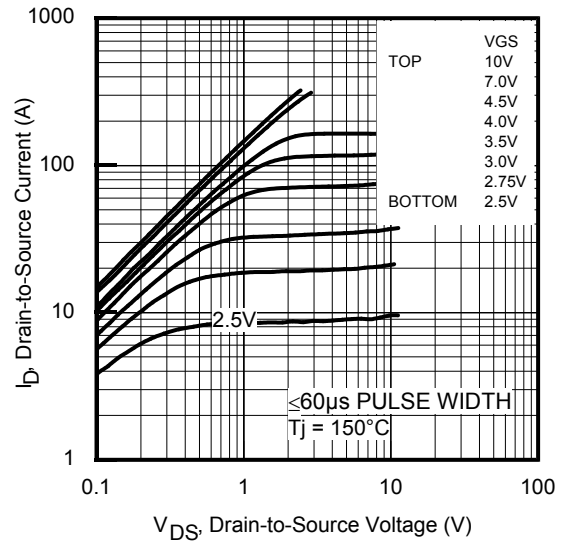
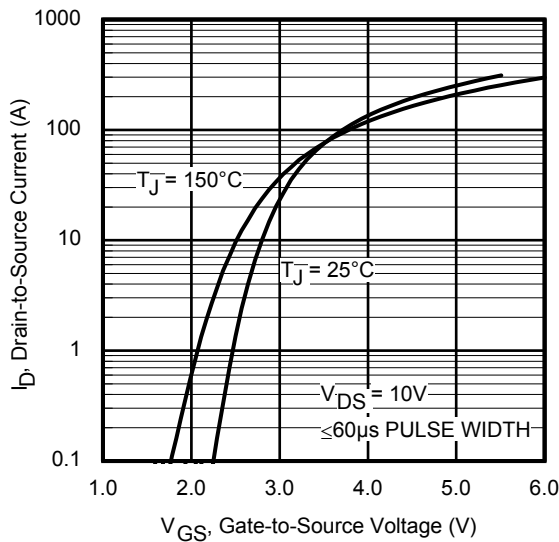
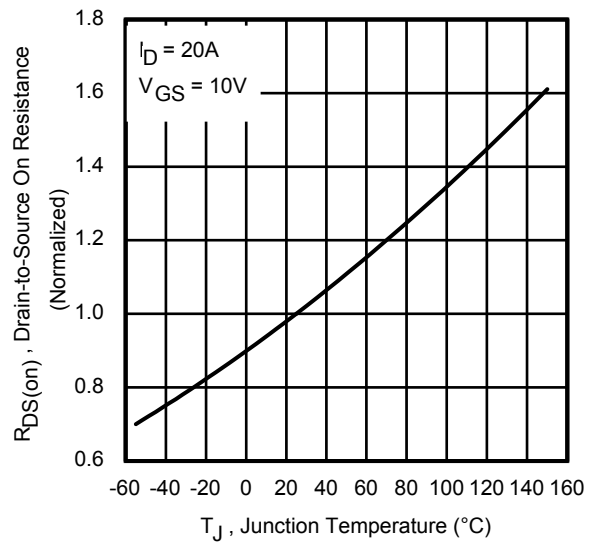
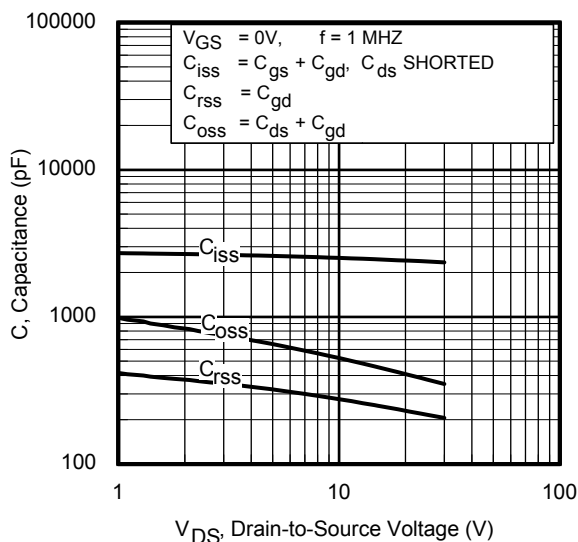
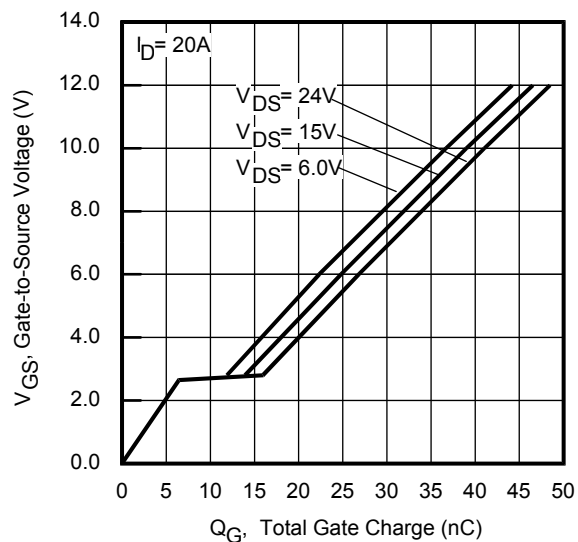
	Parameter	Typ.	Max.
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	—	58
I <sub>AR</sub>	Avalanche Current ①	—	20

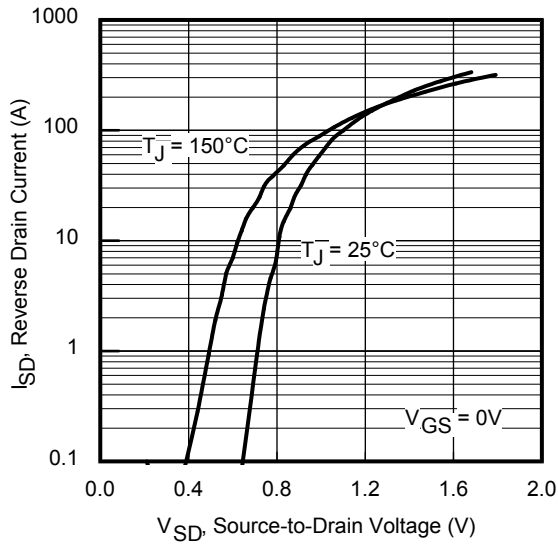
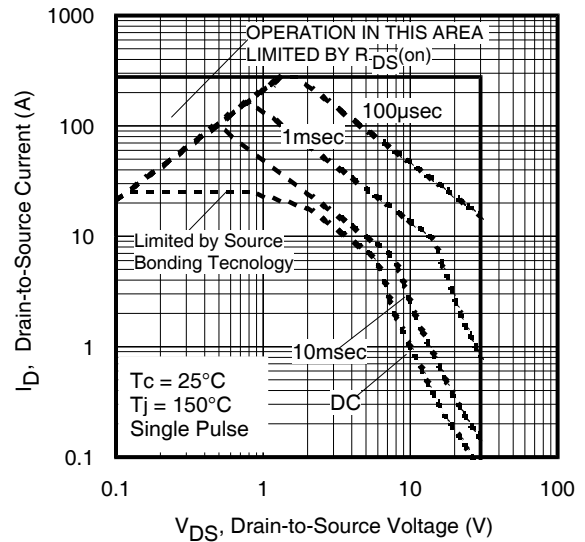
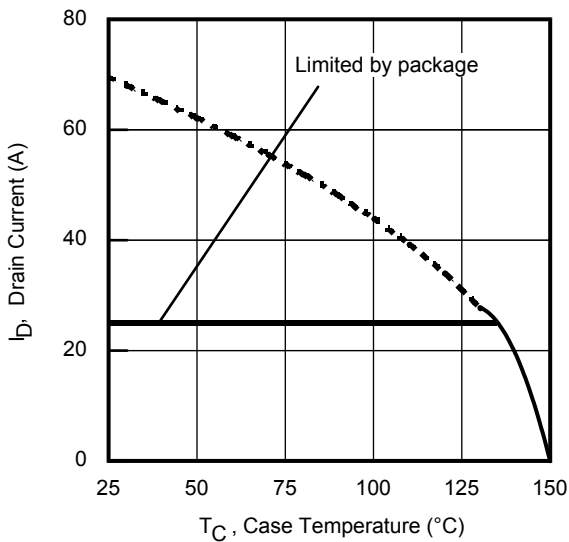
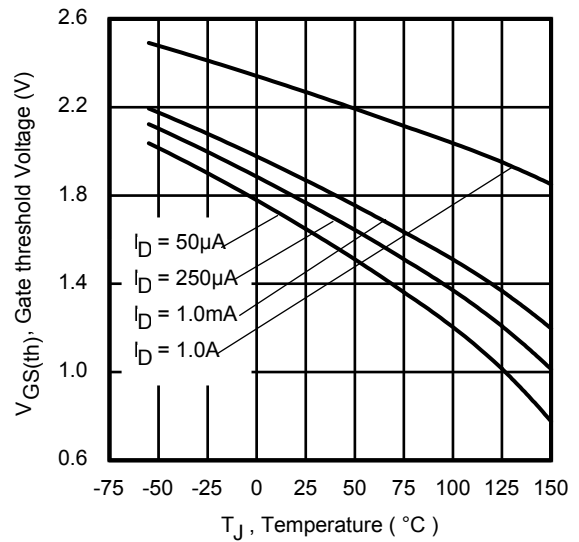
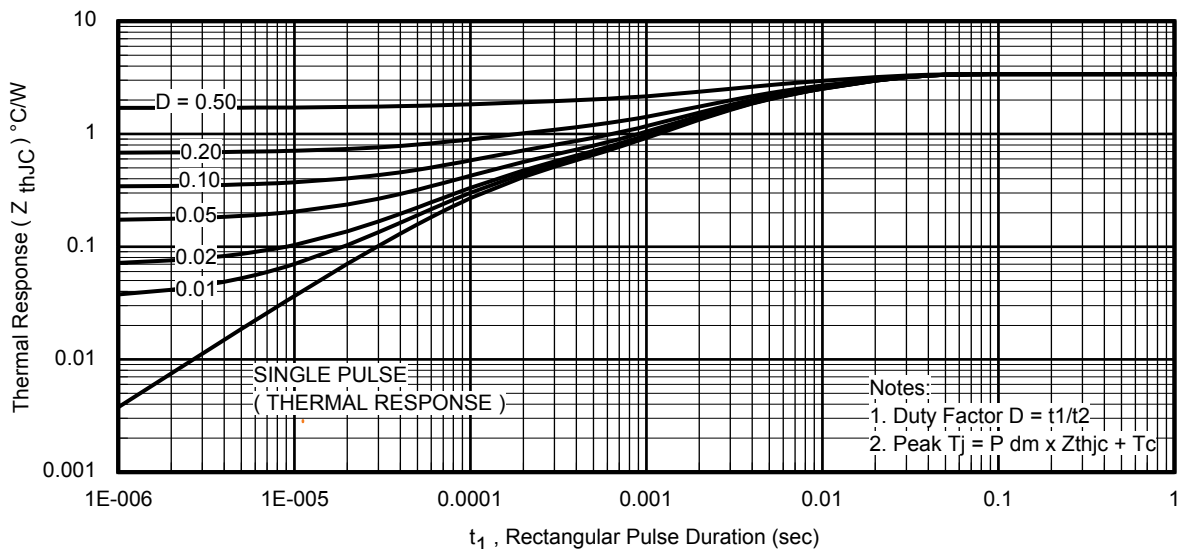
**Diode Characteristics**

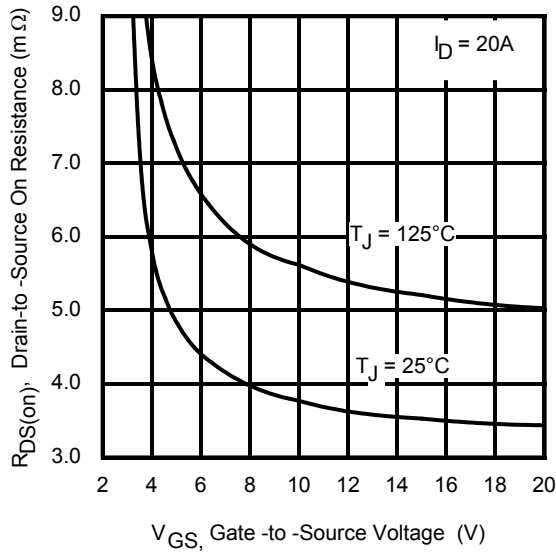
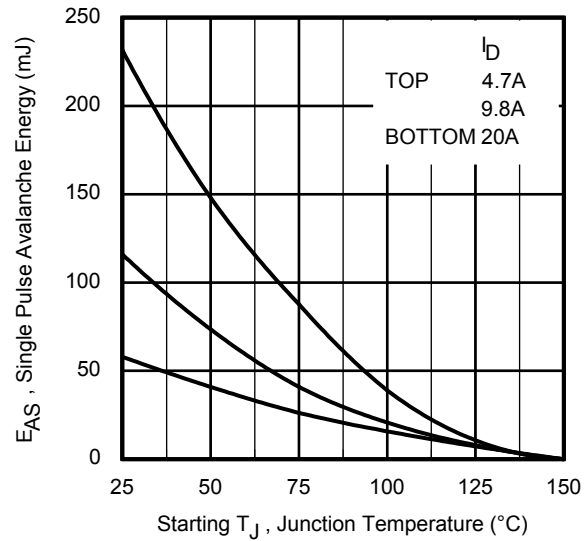
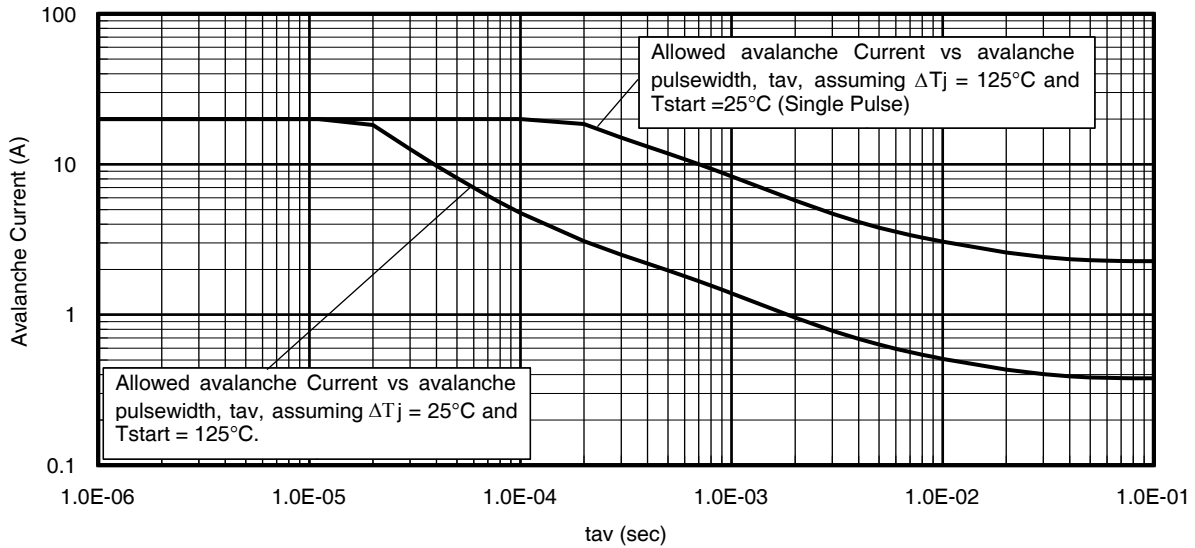
	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	25 ⑦	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	278		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.0	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 20A, V <sub>GS</sub> = 0V ③
t <sub>rr</sub>	Reverse Recovery Time	—	15	23	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 20A, V <sub>DD</sub> = 15V
Q <sub>rr</sub>	Reverse Recovery Charge	—	14	21	nC	di/dt = 300A/μs ③

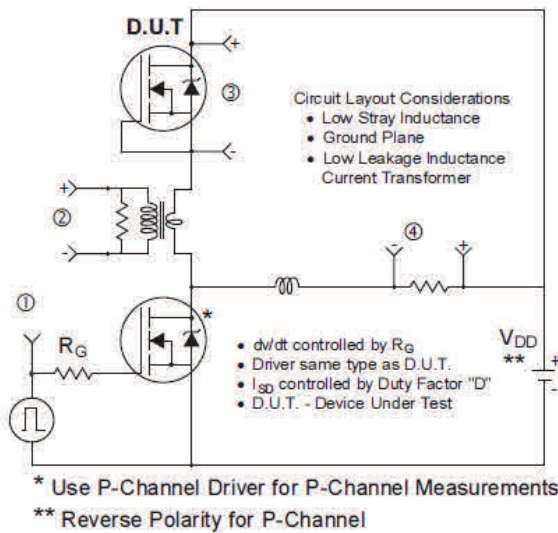
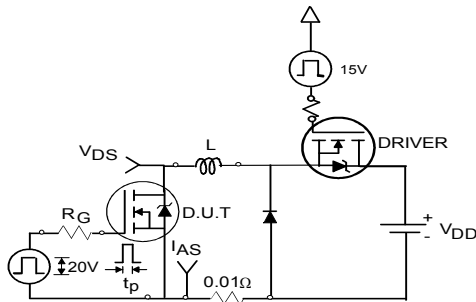
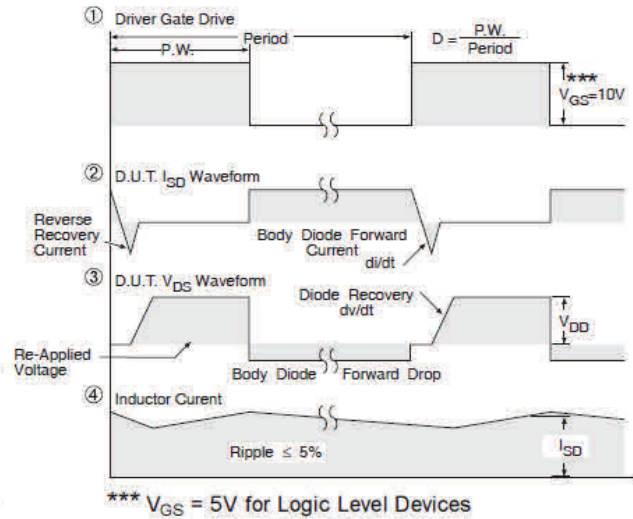
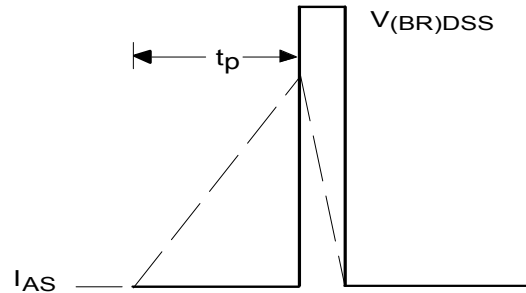
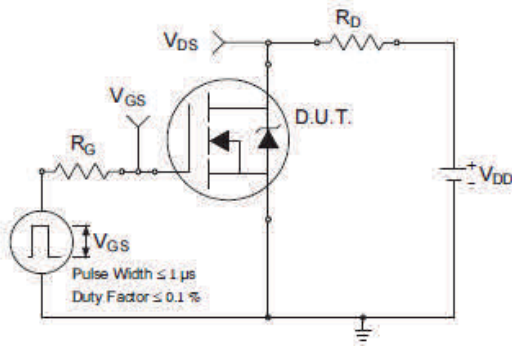
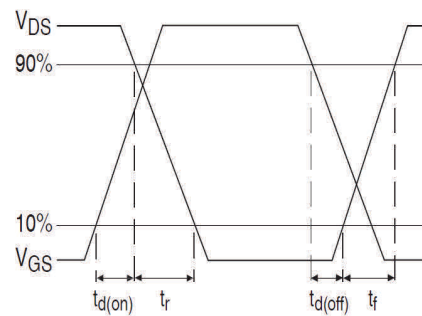
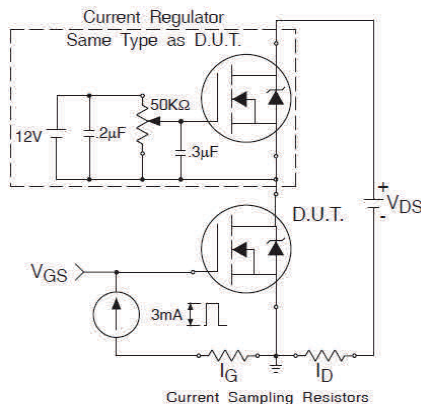
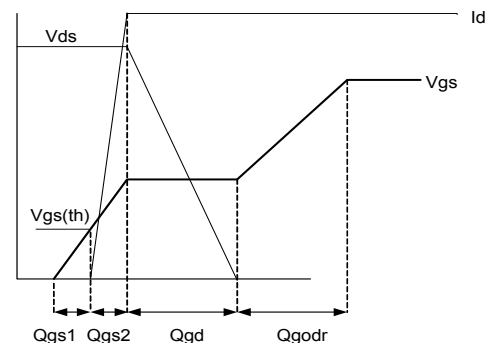
**Thermal Resistance**

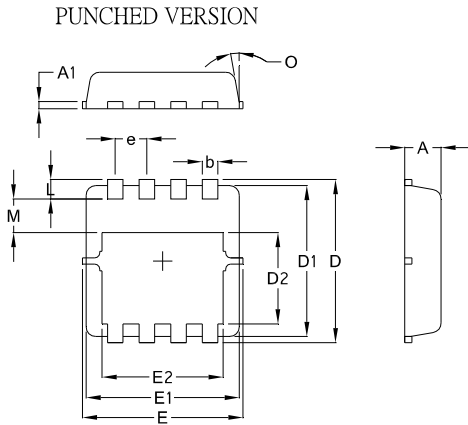
	Parameter	Typ.	Max.	Units
R <sub>θJC</sub> (Bottom)	Junction-to-Case ④	—	3.4	°C/W
R <sub>θJC</sub> (Top)	Junction-to-Case ④	—	41	
R <sub>θJA</sub>	Junction-to-Ambient ⑤	—	44	
R <sub>θJA</sub> (<10s)	Junction-to-Ambient ⑤	—	31	


**Fig 1. Typical Output Characteristics**

**Fig 2. Typical Output Characteristics**

**Fig 3. Typical Transfer Characteristics**

**Fig 4. Normalized On-Resistance vs. Temperature**

**Fig 5. Typical Capacitance vs. Drain-to-Source Voltage**

**Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage**


**Fig 7.** Typical Source-Drain Diode Forward Voltage

**Fig 8.** Maximum Safe Operating Area

**Fig 9.** Maximum Drain Current vs. Case Temperature

**Fig 10.** Drain-to-Source Breakdown Voltage

**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case


**Fig 12.** On-Resistance vs. Gate Voltage

**Fig 13.** Maximum Avalanche Energy vs. Drain Current

**Fig 14.** Typical Avalanche Current vs. Pulsewidth

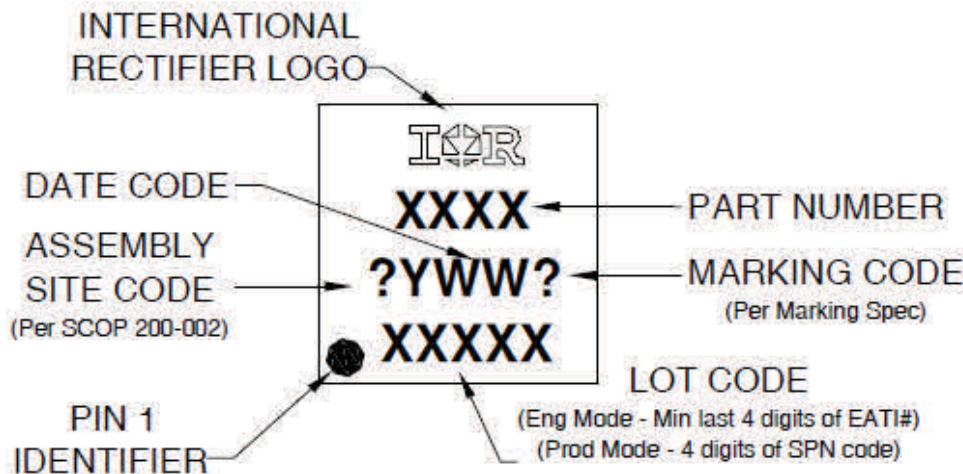

**Fig 15. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs**

**Fig 16a. Unclamped Inductive Test Circuit**

**Fig 16b. Unclamped Inductive Waveforms**

**Fig 17a. Switching Time Test Circuit**

**Fig 17b. Switching Time Waveforms**

**Fig 18a. Gate Charge Test Circuit**

**Fig 18b. Gate Charge Waveform**

**PQFN 3.3mm x 3.3mm Outline Package Details**


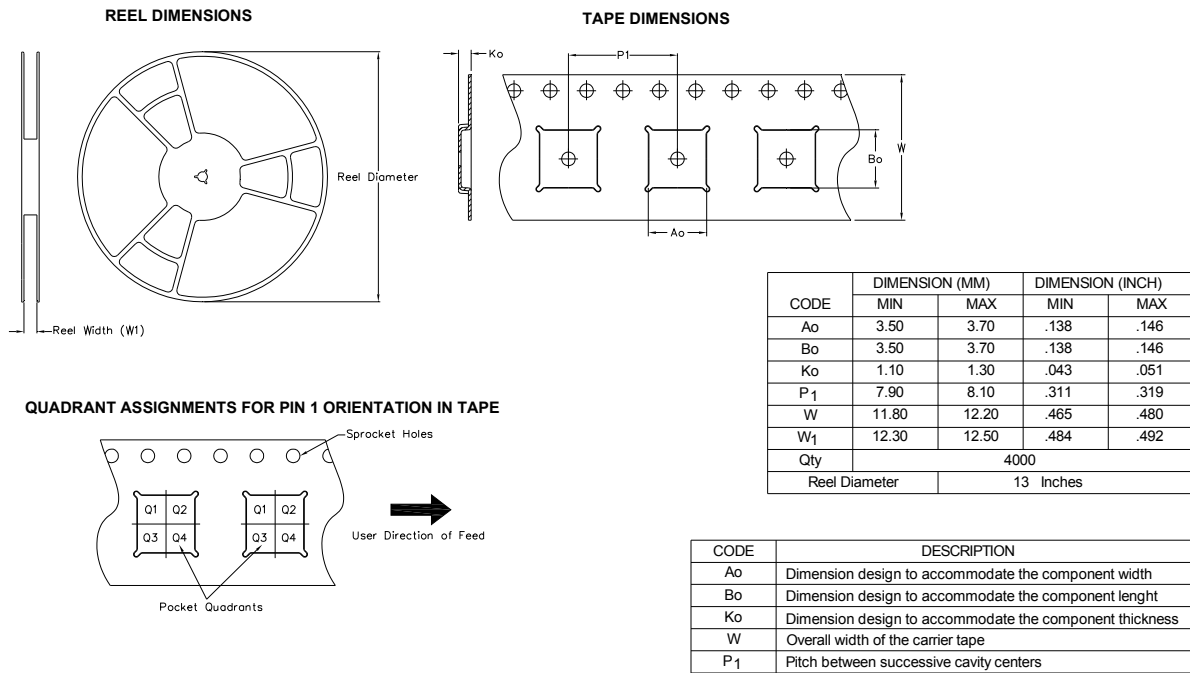
SYMBOL	COMMON			
	MM		INCH	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.05	0.0276	0.0413
A1	0.12	0.39	0.0047	0.0154
b	0.25	0.39	0.0098	0.0154
D	3.20	3.45	0.1260	0.1358
D1	3.00	3.20	0.1181	0.1417
D2	1.69	2.20	0.0665	0.0866
E	3.20	3.40	0.1260	0.1339
E1	3.00	3.20	0.1181	0.1417
E2	2.15	2.59	0.0846	0.1020
e	0.65 BSC		0.0256 BSC	
L	0.15	0.55	0.0059	0.0217
M	0.59	—	0.0232	—
O	9Deg	12Deg	9Deg	12Deg

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <http://www.irf.com/technical-info/appnotes/an-1136.pdf>

For more information on package inspection techniques, please refer to application note AN-1154: <http://www.irf.com/technical-info/appnotes/an-1154.pdf>

**PQFN 3.3mm x 3.3mm Outline Part Marking**


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**PQFN 3.3mm x 3.3mm Outline Tape and Reel**


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>



**Qualification Information<sup>†</sup>**

<b>Qualification Level</b>	Consumer <sup>††</sup> (per JEDEC JESD47F <sup>†††</sup> guidelines)	
<b>Moisture Sensitivity Level</b>	PQFN 3.3mm x 3.3mm	MSL1 (per JEDEC J-STD-020D <sup>†††</sup> )
<b>RoHS Compliant</b>	Yes	

† Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability>

†† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: <http://www.irf.com/whoto-call/salesrep/>

††† Applicable version of JEDEC standard at the time of product release.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.29\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 20\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .
- ⑤ When mounted on 1 inch square 2 oz copper pad on 1.5x1.5 in. board of FR-4 material.
- ⑥ Calculated continuous current based on maximum allowable junction temperature.
- ⑦ Current is limited to 25A by source bonding technology.

**Revision History**

Date	Comments
6/6/14	<ul style="list-style-type: none"> <li>• Updated schematic on page 1</li> <li>• Updated package outline and part marking on page 7</li> <li>• Updated tape and reel on page 8</li> </ul>
6/30/14	<ul style="list-style-type: none"> <li>• Remove "SAWN" package outline on page 7.</li> </ul>